

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10567082	NISHI ET AL
<b>Examiner</b>		<b>Art Unit</b>
Le, H. T		1773

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
428	402	9/17/08	hl
423	334	9/17/08	hl
502	240,407	9/17/08	hl

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
WEST	9/17/07	HL
Continuation & common inventor searched (eDAN)	9/17/07	hl
WEST (updated)	9/17/08	hl

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
428	402	9/17/08	hl
423	335	9/17/08	hl
502	240,407	9/17/08	hl

	/H. T. L./ Primary Examiner.Alt Unit 1794
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